



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10046512</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>HAMASAKA ET AL.</p>
	<p>Examiner</p> <p>Tekle, Daniel</p>	<p>Art Unit</p> <p>2633</p>

Class	SubClass	Date	Examiner
386	95	07/05/06	DT
386	126	07/05/06	DT

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<b>Search Notes</b>  	Application/Control No.  10046512	Applicant(s)/Patent Under Reexamination  HAMASAKA ET AL.
	Examiner Tekle, Daniel	Art Unit 2633

Notes	Date	Examiner
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